

**N-Channel Silicon Junction Field-Effect Transistor****• Low-Noise, High Gain Amplifier****Absolute maximum ratings at  $T_A = 25^\circ\text{C}$** 

Reverse Gate Source & Reverse Gate Drain Voltage	- 20 V
Continuous Forward Gate Current	10 mA
Continuous Device Power Dissipation	225 mW
Power Derating	1.8 mW/ $^\circ\text{C}$
Storage Temperature Range	- 65 $^\circ\text{C}$ to 200 $^\circ\text{C}$

At 25°C free air temperature:

**Static Electrical Characteristics**

	IF1330			Process NJ132H	
	Min	Max	Unit	Test Conditions	
Gate Source Breakdown Voltage	$V_{(\text{BR})\text{GSS}}$	- 20	V	$I_G = - 1 \mu\text{A}$ , $V_{DS} = \emptyset\text{V}$	
Gate Reverse Current	$I_{GSS}$		nA	$V_{DS} = \emptyset\text{V}$ , $V_{GS} = - 10\text{V}$	
Gate Source Cutoff Voltage	$V_{GS(\text{OFF})}$	- 0.35	- 1.5	V	$V_{DS} = 10\text{V}$ , $I_D = 0.5 \text{nA}$
Drain Saturation Current (Pulsed)	$I_{DSS}$	5	20	mA	$V_{DS} = 10\text{V}$ , $V_{GS} = \emptyset\text{V}$

**Dynamic Electrical Characteristics**

Common Source Forward Transconductance	$g_{fs}$	10		mS	$V_{DS} = 10\text{V}$ , $I_D = 5 \text{ mA}$	f = 1 kHz
Common Source Input Capacitance	$C_{iss}$		20	pF	$V_{DS} = 10\text{V}$ , $I_D = 5 \text{ mA}$	f = 1 MHz
Common Source Reverse Transfer Capacitance	$C_{rss}$		5	pF	$V_{DS} = 10\text{V}$ , $I_D = 5 \text{ mA}$	f = 1 MHz

**Typ**

Equivalent Short Circuit Input Noise Voltage	$\bar{e}_N$	2.5	nV/ $\sqrt{\text{Hz}}$	$V_{DS} = 10\text{V}$ , $I_D = 5 \text{ mA}$	f = 1 kHz
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**TO-236AB Package**  
Dimensions in Inches (mm)

**Pin Configuration**  
1 Drain, 2 Source, 3 Gate

